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Application/Control No.	Applicant(s)/Patent under Reexamination
09/871,458	SHAFER, PHILIP
Examiner	Art Unit
Khanh Dinh	2151

	SEAR	CHED	
Class	Subclass	Date	Examiner
Class	Subclass	Date	Examine
709	217, 224 313	4/1/2006	KD
707	102	4/1/2006	KD
719	313	4/1/2006	KD
709	220, 227	4/1/2006	KD

INTERFERENCE SEARCHED				
Subclass	Date	Examiner		
217, 313	4/1/2006	KD		
102	4/1/2006	KD		
313	4/1/2006	KD		
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SEARCH N (INCLUDING SEAR		")
	DATE	EXMR
WEST, NPL, IEEE, ACM	4/1/2006	KD
		